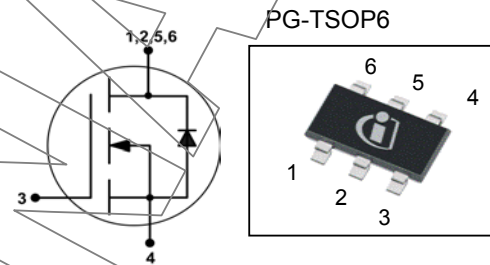


OptiMOS™2 Small-Signal-Transistor
Features

- N-channel
- Enhancement mode
- Ultra Logic level (1.8V rated)
- Avalanche rated
- Qualified according to AEC Q101
- 100% lead-free; RoHS compliant


Product Summary

V_{DS}		20	V
$R_{DS(on),max}$	$V_{GS}=2.5\text{ V}$	22	$m\Omega$
	$V_{GS}=1.8\text{ V}$	31	
I_D		7.5	A



Type	Package	Tape and Reel Information	Marking	Lead Free	Packing
BSL802SN	PG-TSOP6	L6327: 3000 pcs/ reel	sPP	Yes	Non dry

Maximum ratings, at $T_j=25\text{ }^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I_D	$T_A=25\text{ }^\circ\text{C}$	7.5	A
		$T_A=70\text{ }^\circ\text{C}$	6.0	
Pulsed drain current	$I_{D,pulse}$	$T_A=25\text{ }^\circ\text{C}$	30	
Avalanche energy, single pulse	E_{AS}	$I_D=7.5\text{ A}$, $R_{GS}=25\ \Omega$	30	mJ
Reverse diode dv/dt	dv/dt	$I_D=7.5\text{ A}$, $V_{DS}=16\text{ V}$, $di/dt=200\text{ A}/\mu\text{s}$, $T_{j,max}=150\text{ }^\circ\text{C}$	6	kV/ μs
Gate source voltage	V_{GS}		± 8	V
Power dissipation ¹⁾	P_{tot}	$T_A=25\text{ }^\circ\text{C}$	2	W
Operating and storage temperature	T_j , T_{stg}		-55 ... 150	$^\circ\text{C}$
ESD Class		JESD22-C101 -HBM	0 (<250V)	
Soldering Temperature			260 $^\circ\text{C}$	
IEC climatic category; DIN IEC 68-1			55/150/56	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Thermal characteristics

Thermal resistance, junction - minimal footprint	R_{thJS}		-	-	50	K/W
SMD version, device on PCB	R_{thJA}	minimal footprint	-	-	230	
		6 cm ² cooling area ¹⁾	-	-	62.5	

Electrical characteristics, at $T_j=25\text{ }^\circ\text{C}$, unless otherwise specified
Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{ V}, I_D=250\text{ }\mu\text{A}$	20	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=0\text{ V}, I_D=30\text{ }\mu\text{A}$	0.3	0.55	0.75	
Drain-source leakage current	I_{DSS}	$V_{DS}=20\text{ V}, V_{GS}=0\text{ V}, T_j=25\text{ }^\circ\text{C}$	-	-	1	μA
		$V_{DS}=20\text{ V}, V_{GS}=0\text{ V}, T_j=150\text{ }^\circ\text{C}$	-	-	100	
Gate-source leakage current	I_{GSS}	$V_{GS}=8\text{ V}, V_{DS}=0\text{ V}$	-	-	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=1.8\text{ V}, I_D=3.6\text{ A}$	-	23	31	$\text{m}\Omega$
		$V_{GS}=2.5\text{ V}, I_D=7.5\text{ A}$	-	18	22	
Transconductance	g_{fs}	$ V_{DS} >2 I_D R_{DS(on)max}, I_D=6\text{ A}$		25	-	S

¹⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (single layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air. ($t < 5\text{ sec.}$)

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Dynamic characteristics

Input capacitance	C_{iss}	$V_{GS}=0\text{ V}, V_{DS}=10\text{ V},$ $f=1\text{ MHz}$	-	1013	1347	pF
Output capacitance	C_{oss}		-	290	385	
Reverse transfer capacitance	C_{rss}		-	51	77	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=10\text{ V}, V_{GS}=2.5\text{ V},$ $I_D=3.7\text{ A}, R_G=6\ \Omega$	-	10	-	ns
Rise time	t_r		-	30	-	
Turn-off delay time	$t_{d(off)}$		-	20	-	
Fall time	t_f		-	5.5	-	

Gate Charge Characteristics

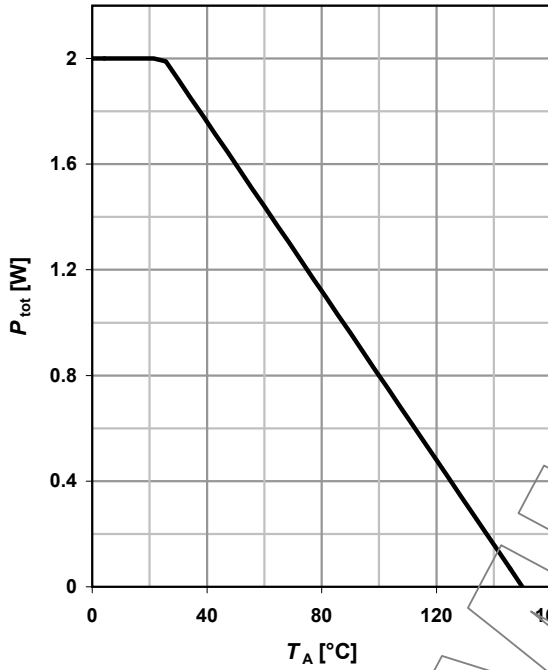
Gate to source charge	Q_{gs}	$V_{DD}=10\text{ V}, I_D=7.5\text{ A},$ $V_{GS}=0\text{ to }2.5\text{ V}$	-	1.6	-	nC
Gate to drain charge	Q_{gd}		-	1.6	-	
Gate charge total	Q_g		-	4.7	-	
Gate plateau voltage	$V_{plateau}$		-	1.5	-	V

Reverse Diode

Diode continuous forward current	I_s	$T_A=25\text{ }^\circ\text{C}$	-	-	1.8	A
Diode pulse current	$I_{s,pulse}$		-	-	30	
Diode forward voltage	V_{SD}	$V_{GS}=0\text{ V}, I_F=7.5\text{ A},$ $T_j=25\text{ }^\circ\text{C}$	-	0.86	1.1	V
Reverse recovery time	t_{rr}	$V_R=10\text{ V}, I_F=7.5\text{ A},$ $di_F/dt=100\text{ A}/\mu\text{s}$	-	15	-	ns
Reverse recovery charge	Q_{rr}		-	5.1	-	

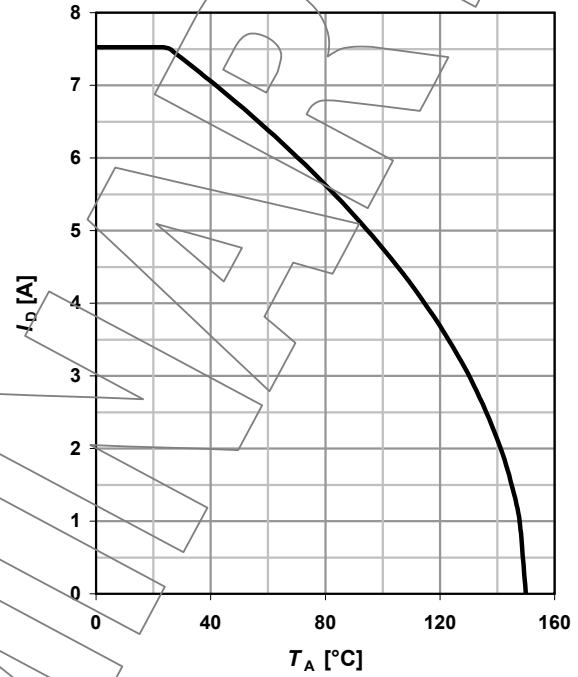
1 Power dissipation

$P_{tot} = f(T_A)$



2 Drain current

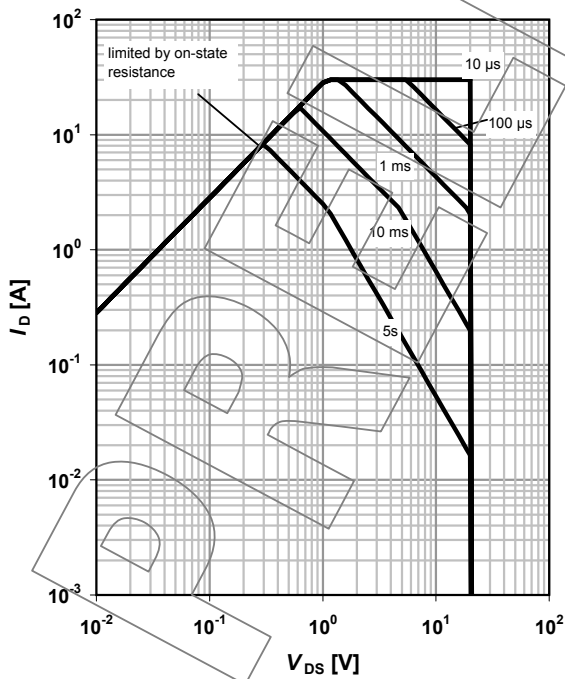
$I_D = f(T_A); V_{GS} \geq 2.5 V$



3 Safe operating area

$I_D = f(V_{DS}); T_A = 25^\circ C; D = 0$

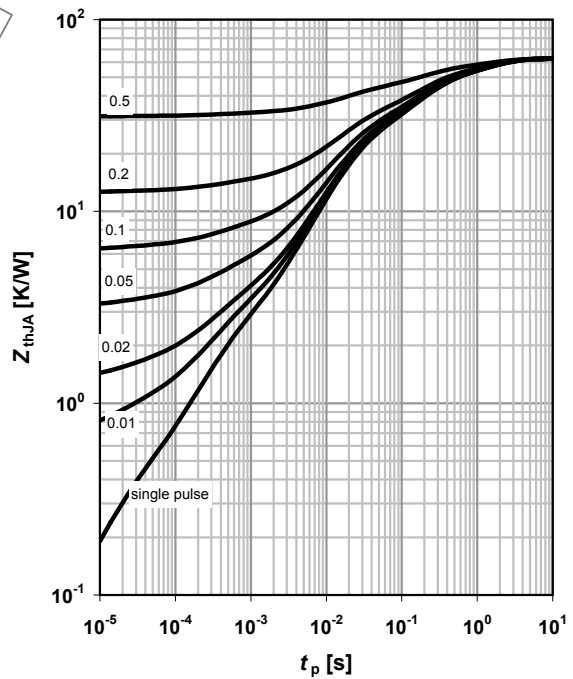
parameter: t_p



4 Max. transient thermal impedance

$Z_{thJA} = f(t_p)$

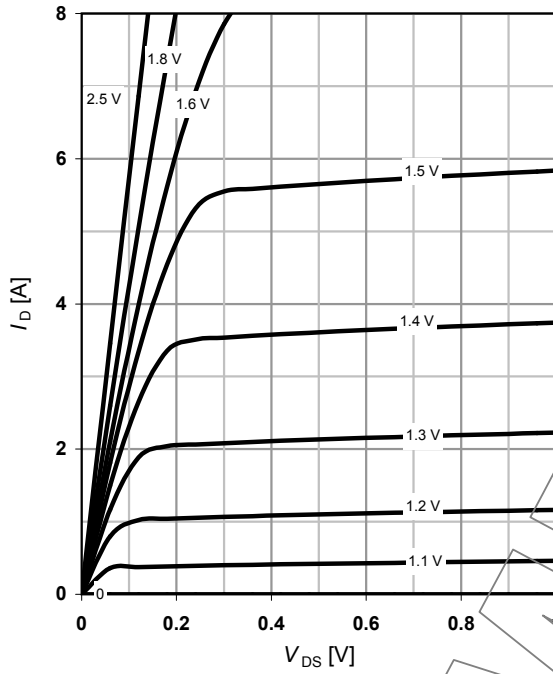
parameter: $D = t_p / T$



5 Typ. output characteristics

$I_D = f(V_{DS}); T_j = 25\text{ }^\circ\text{C}$

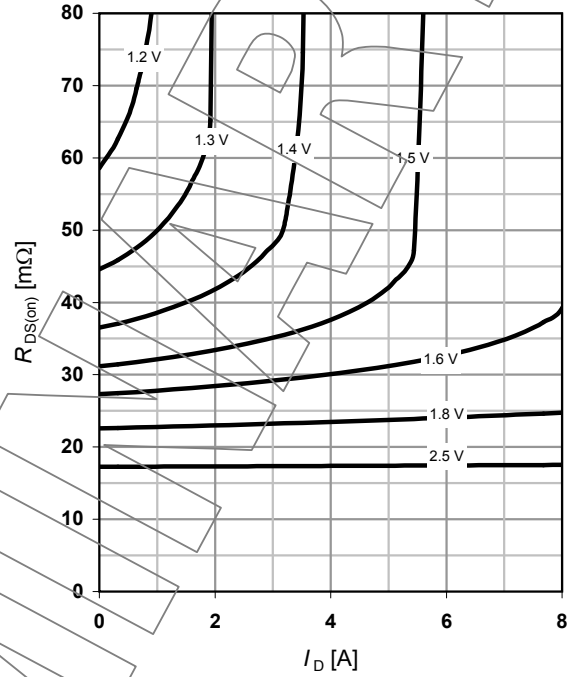
parameter: V_{GS}



6 Typ. drain-source on resistance

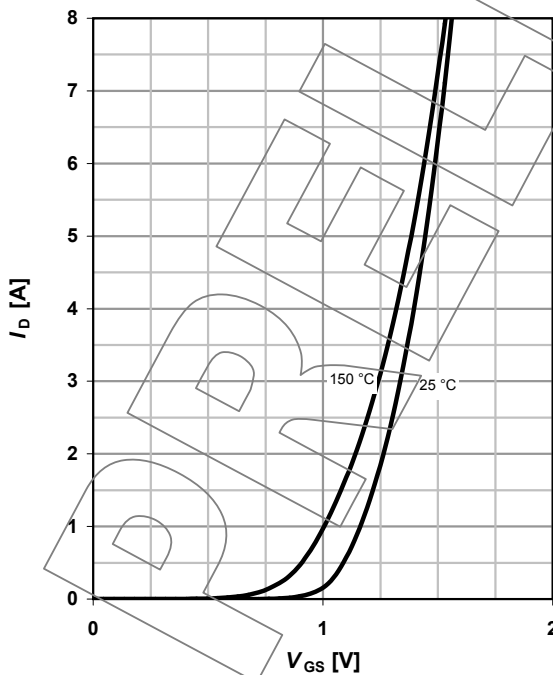
$R_{DS(on)} = f(I_D); T_j = 25\text{ }^\circ\text{C}$

parameter: V_{GS}



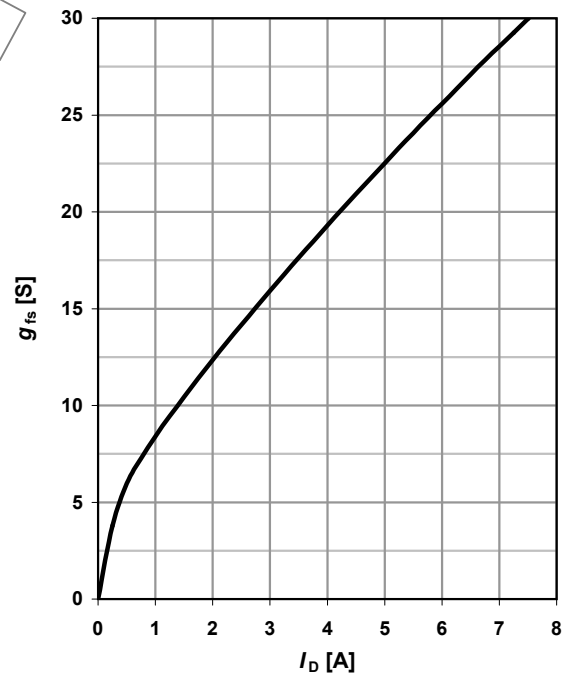
7 Typ. transfer characteristics

$I_D = f(V_{GS}); |V_{DS}| > 2|I_D|R_{DS(on)max}$



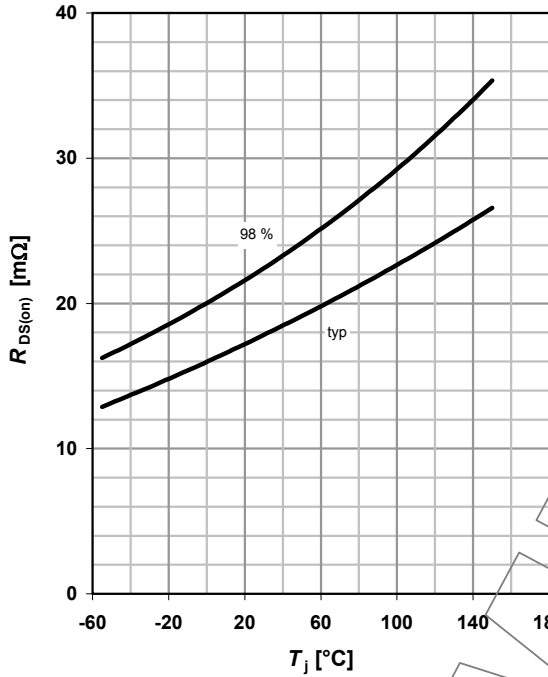
8 Typ. forward transconductance

$g_{fs} = f(I_D); T_j = 25\text{ }^\circ\text{C}$



9 Drain-source on-state resistance

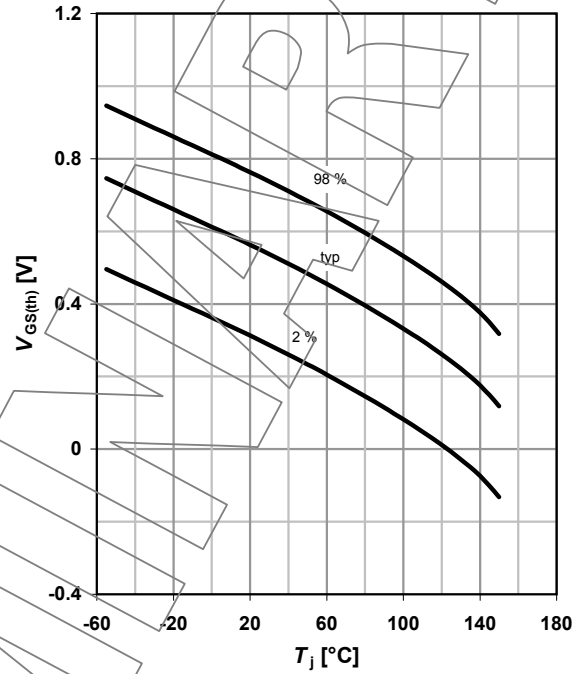
$R_{DS(on)} = f(T_j); I_D = 7.5 \text{ A}; V_{GS} = 2.5 \text{ V}$



10 Typ. gate threshold voltage

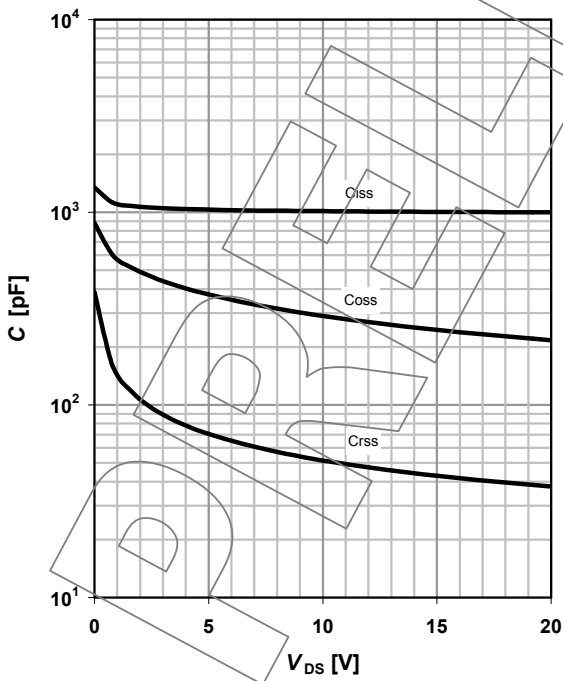
$V_{GS(th)} = f(T_j); V_{DS} = V_{GS}; I_D = 30 \mu\text{A}$

parameter: I_D



11 Typ. capacitances

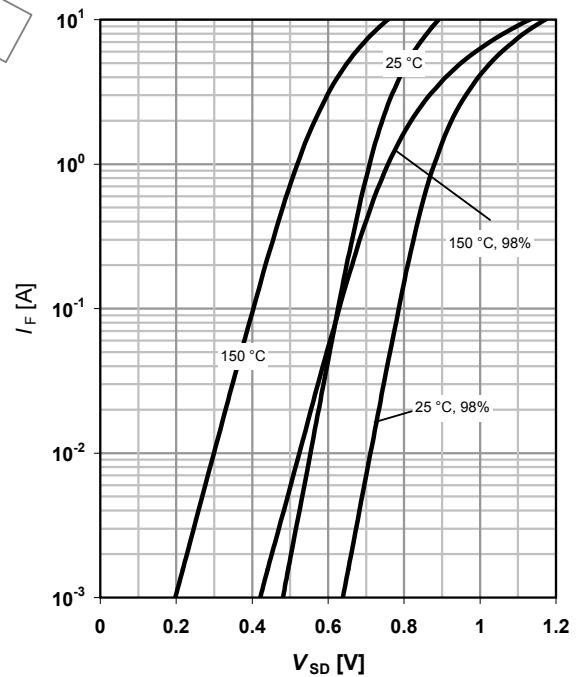
$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}; T_j = 25^\circ\text{C}$



12 Forward characteristics of reverse diode

$I_F = f(V_{SD})$

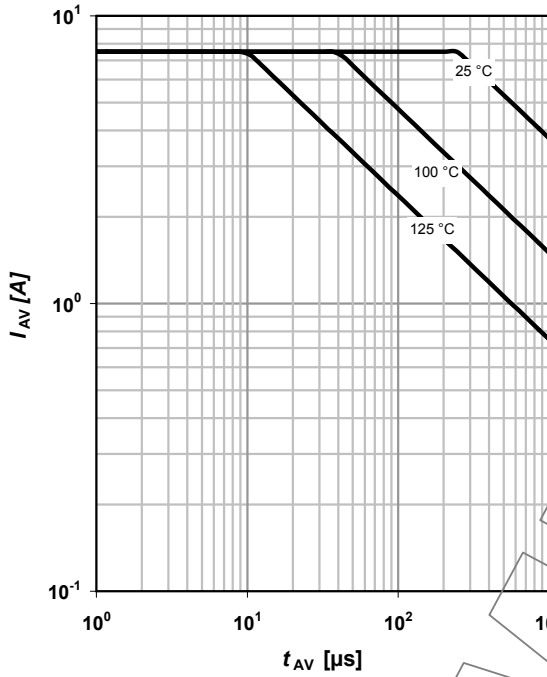
parameter: T_j



13 Avalanche characteristics

$I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$

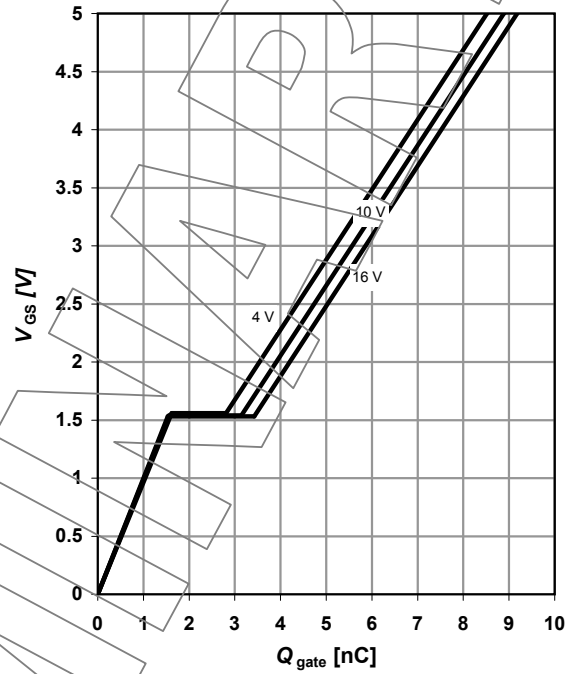
parameter: $T_{j(start)}$



14 Typ. gate charge

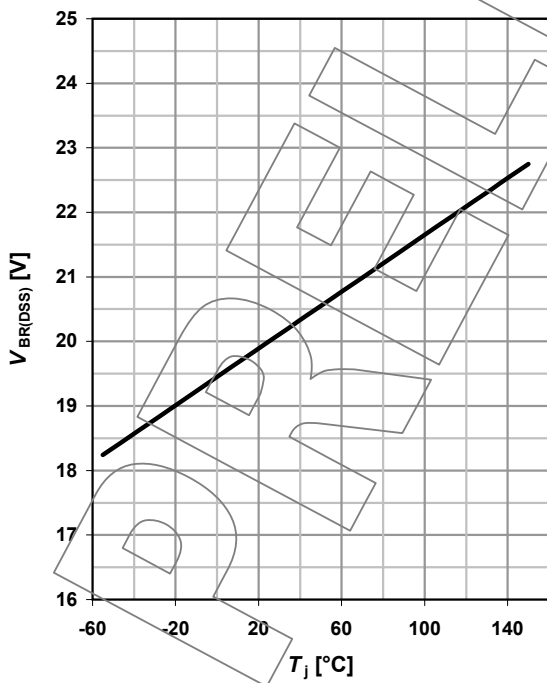
$V_{GS}=f(Q_{gate}); I_D=7.5 \text{ A pulsed}$

parameter: V_{DD}

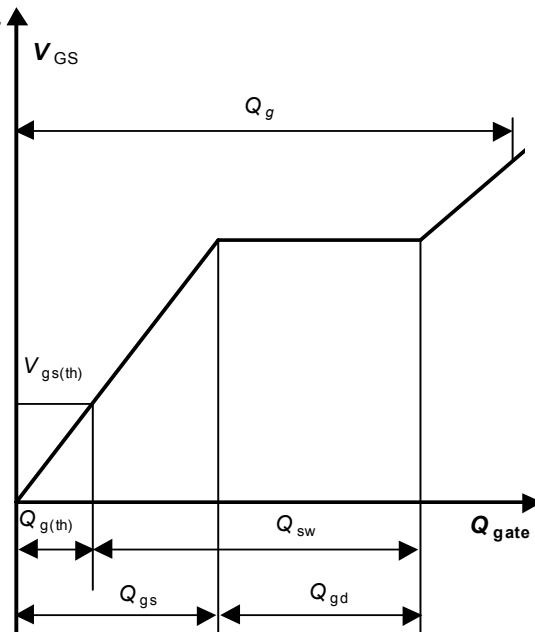


15 Drain-source breakdown voltage

$V_{BR(DSS)}=f(T_j); I_D=250 \mu A$

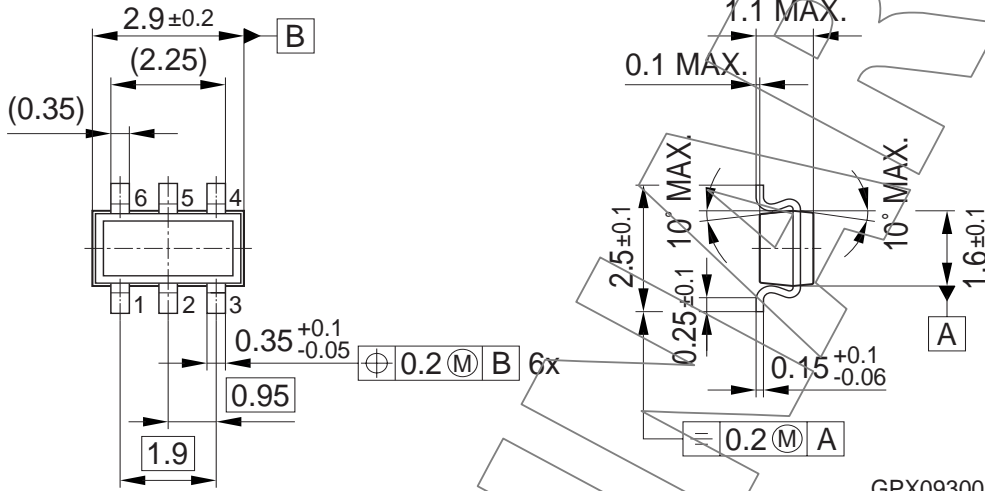


16 Gate charge waveforms

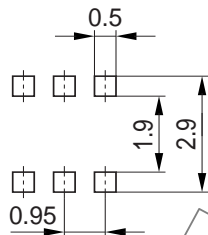


TSOP6

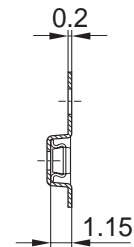
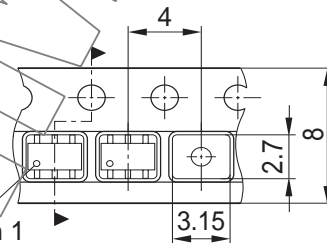
Package Outline:



Footprint:



Packaging:



Remark: Wave soldering possible dep. on customers process conditions

HLG09283

Dimensions in mm

PRELIMINARY

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